Issue Classification	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10790168	SOBCHAK ET AL.
	Examiner	Art Unit
	Lee, Siu M	2611

ORIGINAL		INTERNATIONAL CLASSIFICATION															
CLASS	SUBCLASS	CLAIMED								NON-CLAIMED							
375	346	H	0	3	D	1 / 04 (2006.01.01)											

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
375	144	229	316	346	350
455	67.11	63.1	522		

Lee, Siu M	9/24/2007		Total Claims Allowed:	
(Assistant Examiner)	(Date)	*Chieh M*	37	
(Legal Instruments Examiner)	9-28-07 (Date)	CHIEH M. FAN SUPERVISORY PATENT EXAMINER (Primary Examiner) (Date)	O.G. Print Claim(s) 1	O.G. Print Figure 2